

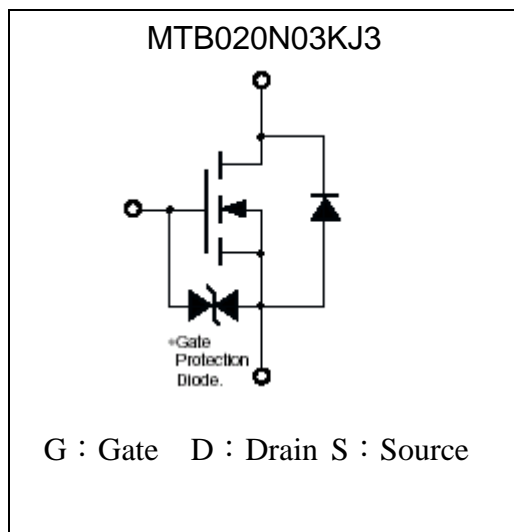
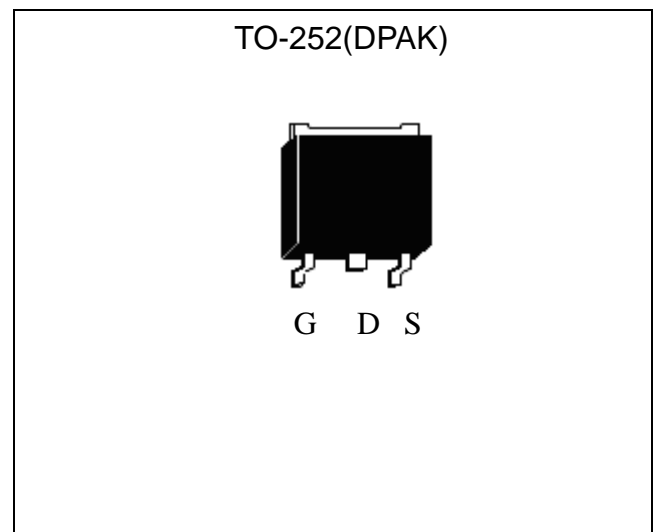
N-Channel Enhancement Mode Power MOSFET

MTB020N03KJ3

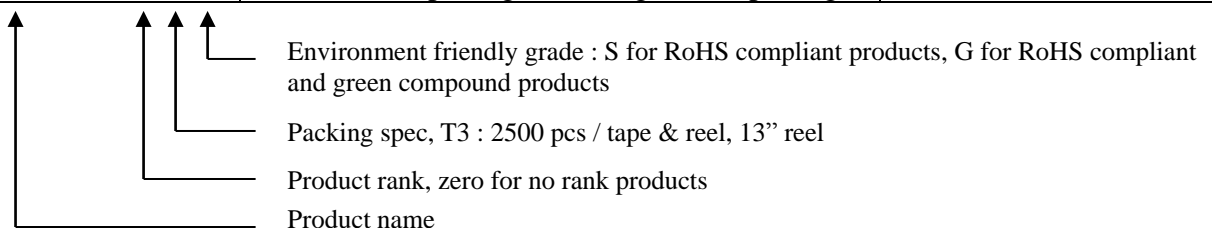
BV_{DSS}	30V	
$I_D @ V_{GS}=10V, T_C=25^\circ C$	30A	
$I_D @ V_{GS}=10V, T_A=25^\circ C$	9A	
$R_{DSON(TYP)}$	$V_{GS}=10V, I_D=20A$	13m Ω
	$V_{GS}=4.5V, I_D=10A$	18m Ω
	$V_{GS}=4V, I_D=10A$	21m Ω

Features

- Low Gate Charge
- Simple Drive Requirement
- ESD Protected Gate
- Pb-free lead plating and halogen-free package

Equivalent Circuit

Outline

Ordering Information

Device	Package	Shipping
MTB020N03KJ3-0-T3-G	TO-252 (Pb-free lead plating and halogen-free package)	2500 pcs / Tape & Reel



**Absolute Maximum Ratings** ($T_C=25^{\circ}\text{C}$)

Parameter		Symbol	Limits	Unit
Drain-Source Voltage (Note 1)		V_{DS}	30	V
Gate-Source Voltage		V_{GS}	± 20	
Continuous Drain Current @ $T_C=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (Note 1)		I_D	30	A
Continuous Drain Current @ $T_C=100^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (Note 1)			19	
Continuous Drain Current @ $T_A=25^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (Note 2)		I_{DSM}	9	
Continuous Drain Current @ $T_A=100^{\circ}\text{C}$, $V_{GS}=10\text{V}$ (Note 2)			5.7	
Pulsed Drain Current @ $V_{GS}=10\text{V}$ (Note 3)		I_{DM}	100	
Single Pulse Avalanche Current @ $L=0.1\text{mH}$		I_{AS}	21	
Single Pulse Avalanche Energy @ $L=5\text{mH}$, $I_D=6\text{A}$, $V_{DD}=15\text{V}$ (Note 4)		E_{AS}	90	mJ
Power Dissipation	$T_C=25^{\circ}\text{C}$ (Note 1)	P_D	50	W
	$T_C=100^{\circ}\text{C}$ (Note 1)		20	
	$T_A=25^{\circ}\text{C}$ (Note 2)	P_{DSM}	2.5	
	$T_A=100^{\circ}\text{C}$ (Note 2)		1.0	
Operating Junction and Storage Temperature		T_j, T_{stg}	-55~+150	$^{\circ}\text{C}$

Thermal Data

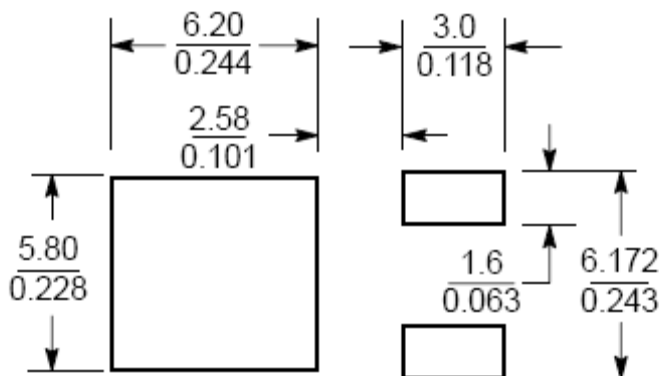
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-case, max	$R_{\theta JC}$	2.5	$^{\circ}\text{C}/\text{W}$
Thermal Resistance, Junction-to-ambient, max (Note 2)	$R_{\theta JA}$	50	

- Note : 1. The power dissipation P_D is based on $T_{J(\text{MAX})}=150^{\circ}\text{C}$, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
2. The value of $R_{\theta JA}$ is measured with the device mounted on 1 in² FR-4 board with 2 oz. copper, in a still air environment with $T_A=25^{\circ}\text{C}$. The power dissipation P_{DSM} is based on $R_{\theta JA}$ and the maximum allowed junction temperature of 150°C .
3. Pulse width limited by junction temperature $T_{J(\text{MAX})}=150^{\circ}\text{C}$. Ratings are based on low frequency and low duty cycles to keep initial $T_j=25^{\circ}\text{C}$.
4. 100% tested by conditions of $L=100\ \mu\text{H}$, $I_{AS}=10\text{A}$, $V_{GS}=10\text{V}$, $V_{DD}=15\text{V}$

Characteristics (Tc=25°C, unless otherwise specified)

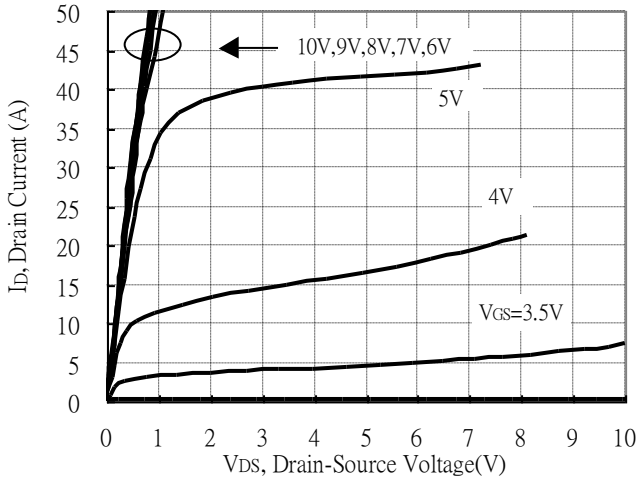
Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV _{DSS}	30	-	-	V	V _{GS} =0V, I _D =250μA
V _{GS(th)}	1	-	2.5		V _{DS} =V _{GS} , I _D =250μA
I _{GSS}	-	-	±10	μA	V _{GS} =±16V, V _{DS} =0V
I _{DSS}	-	-	1		V _{DS} =30V, V _{GS} =0V
	-	-	25		V _{DS} =30V, V _{GS} =0V, T _J =70°C
R _{DS(ON)} *1	-	13	17	mΩ	V _{GS} =10V, I _D =20A
	-	18	24		V _{GS} =4.5V, I _D =10A
	-	21	28		V _{GS} =4V, I _D =10A
G _{FS} *1	-	3.5	-	S	V _{DS} =10V, I _D =3A
Dynamic					
Q _g *1, 2	-	12	-	nC	V _{DS} =15V, I _D =20A, V _{GS} =10V
Q _{gs} *1, 2	-	2.2	-		
Q _{gd} *1, 2	-	3.4	-		
t _{d(ON)} *1, 2	-	6.4	-	ns	V _{DS} =15V, I _D =1A, V _{GS} =10V, R _G =6Ω
t _r *1, 2	-	17.2	-		
t _{d(OFF)} *1, 2	-	30.8	-		
t _f *1, 2	-	10.8	-		
C _{iss}	-	440	-	pF	V _{GS} =0V, V _{DS} =25V, f=1MHz
C _{oss}	-	61.7	-		
C _{rss}	-	46	-		
Source-Drain Diode					
V _{SD} *1	-	0.91	1.2	V	I _S =15A, V _{GS} =0V
t _{rr}	-	5.6	-	ns	I _F =20A, dI _F /dt=100A/μs
Q _{rr}	-	1.7	-	nC	

Note : *1.Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%
 *2.Independent of operating temperature
 *3.Pulse width limited by maximum junction temperature.

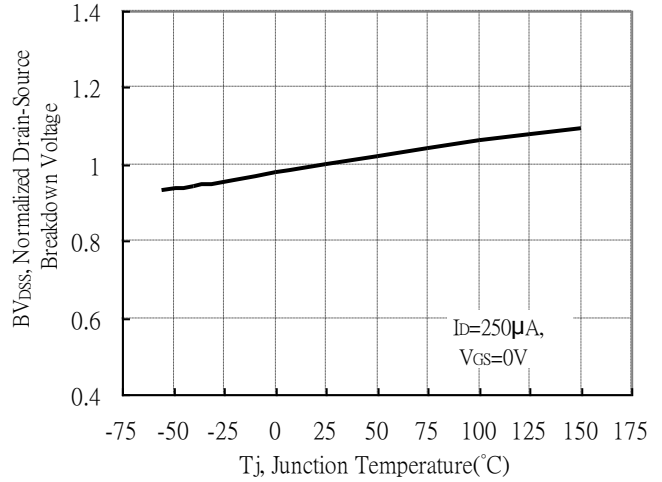
Recommended soldering footprint

 Unit ($\frac{\text{mm}}{\text{inch}}$)

Typical Characteristics

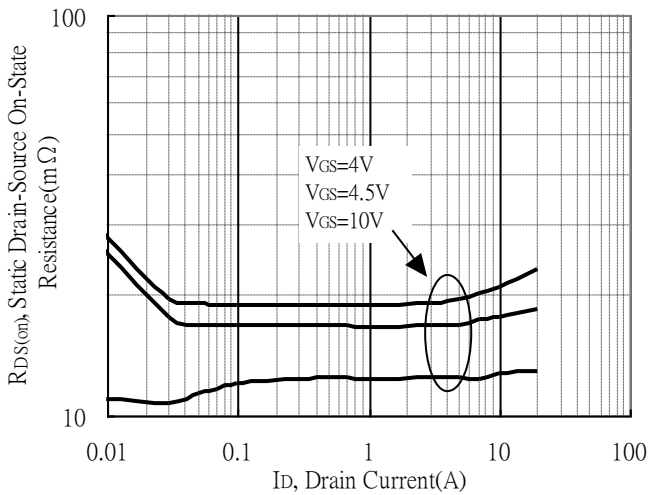
Typical Output Characteristics



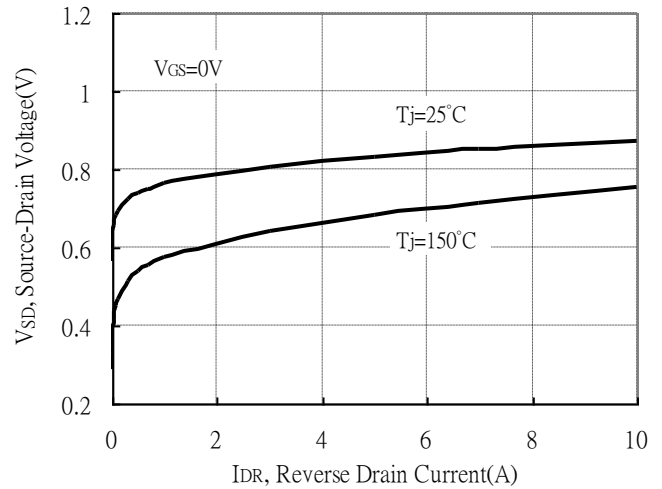
Brekdown Voltage vs Ambient Temperature



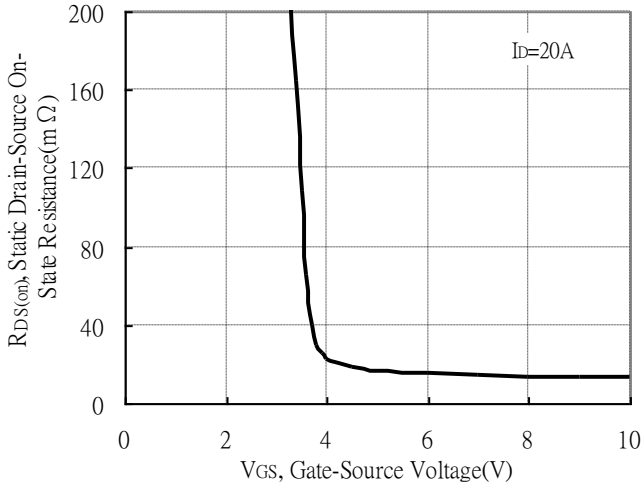
Static Drain-Source On-State resistance vs Drain Current



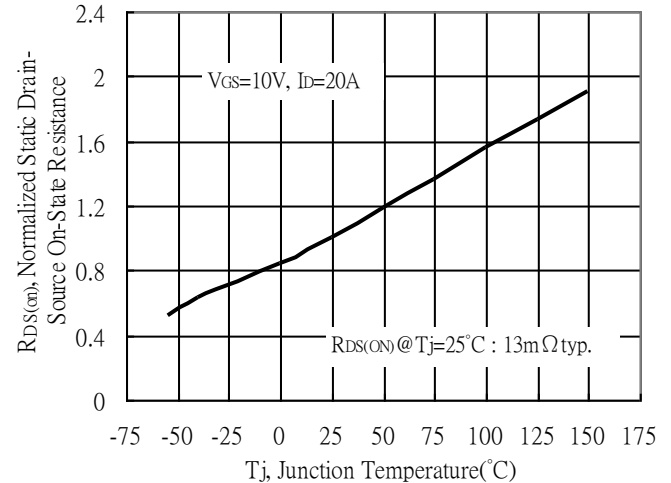
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

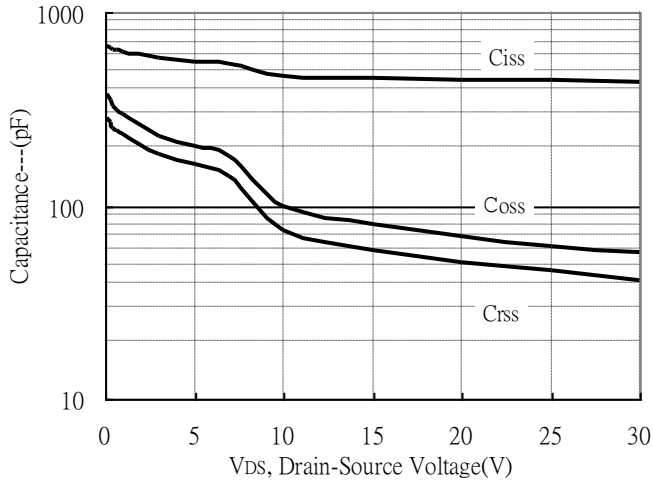


Drain-Source On-State Resistance vs Junction Temperature

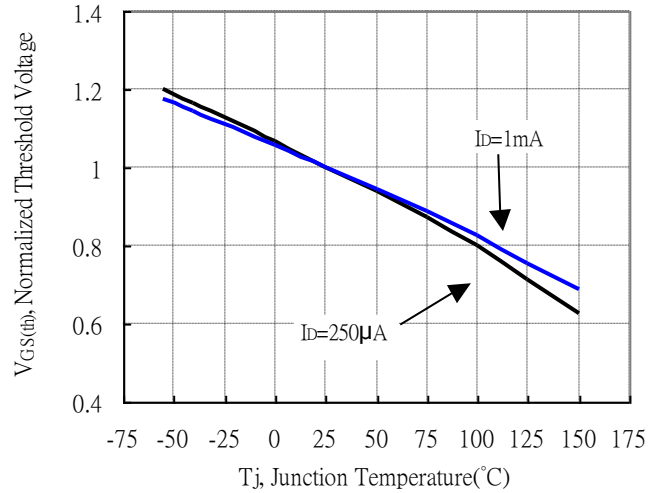


Typical Characteristics(Cont.)

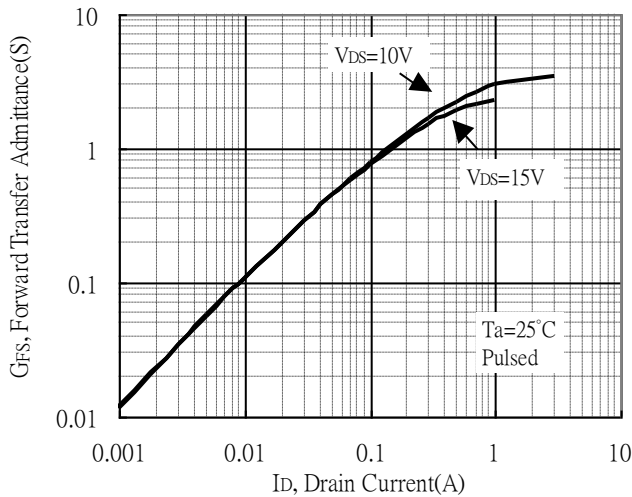
Capacitance vs Drain-to-Source Voltage



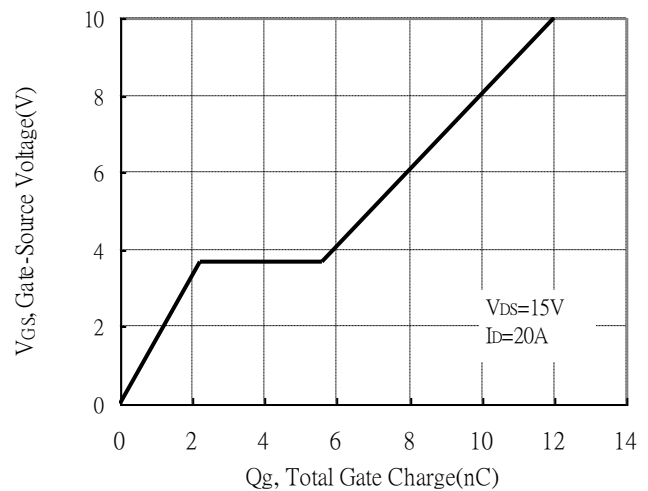
Threshold Voltage vs Junction Temperature



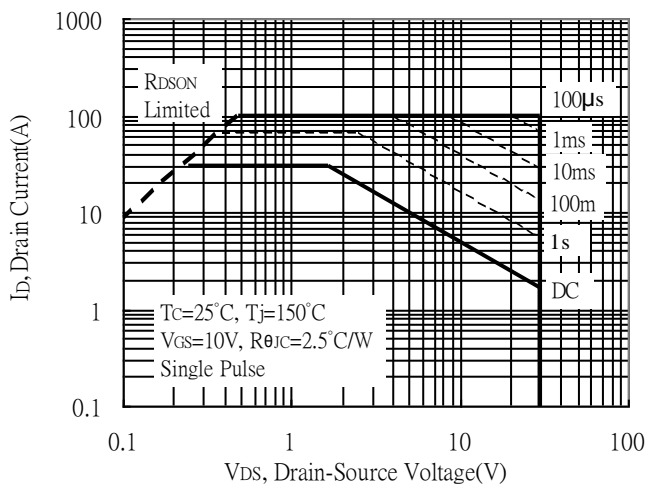
Forward Transfer Admittance vs Drain Current



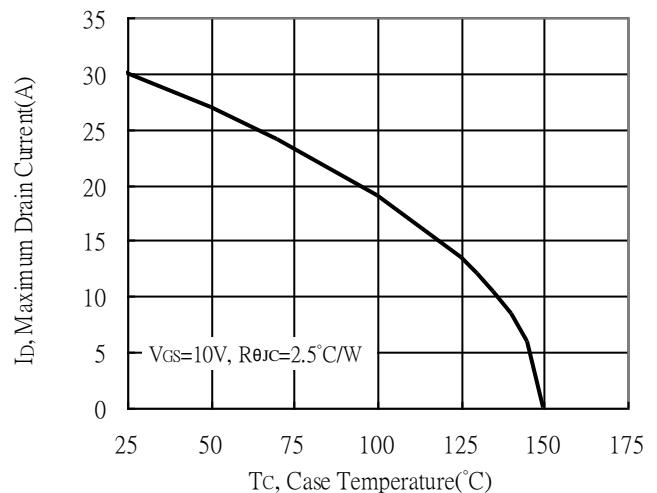
Gate Charge Characteristics



Maximum Safe Operating Area

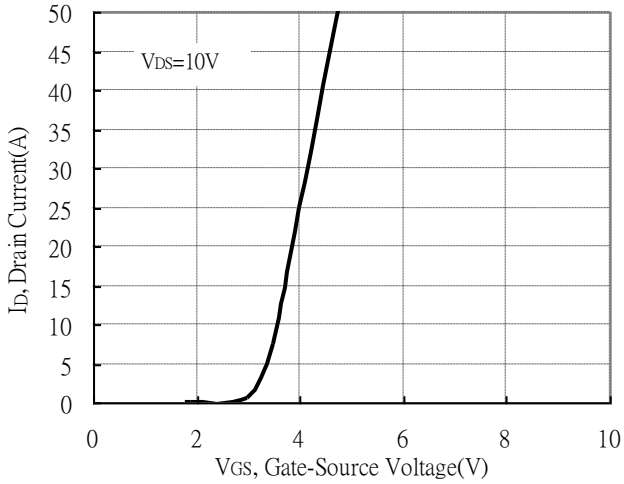


Maximum Drain Current vs Case Temperature

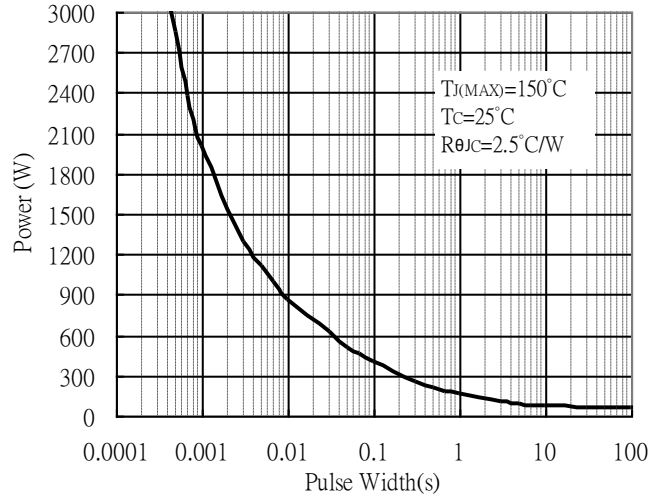


Typical Characteristics(Cont.)

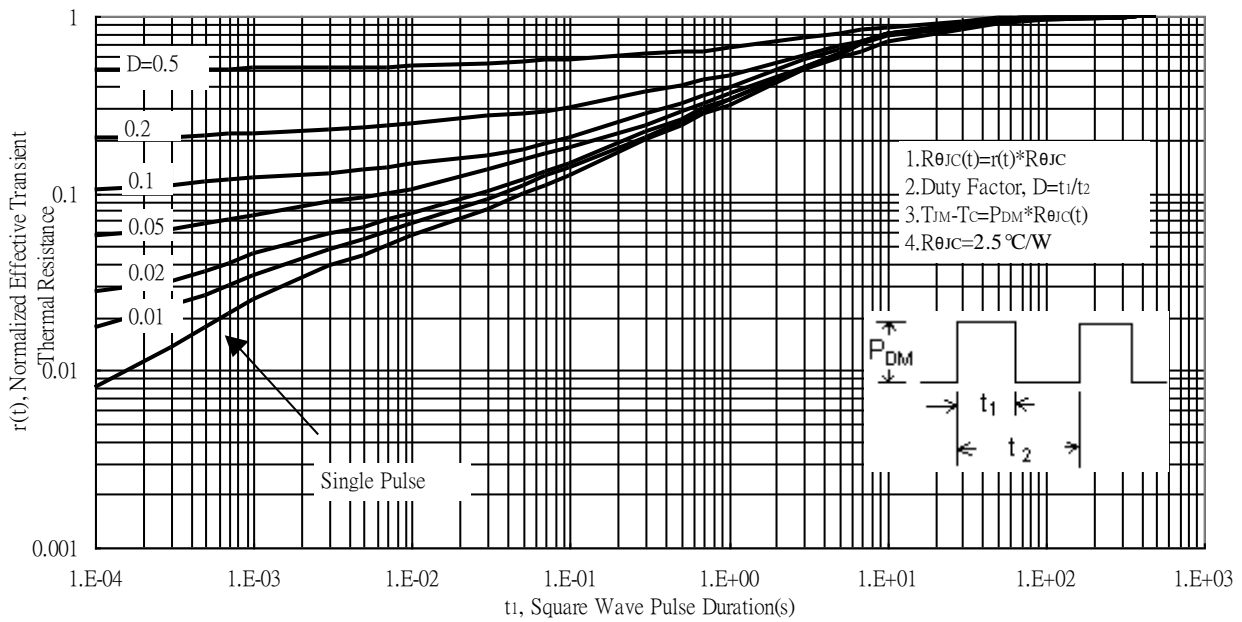
Typical Transfer Characteristics



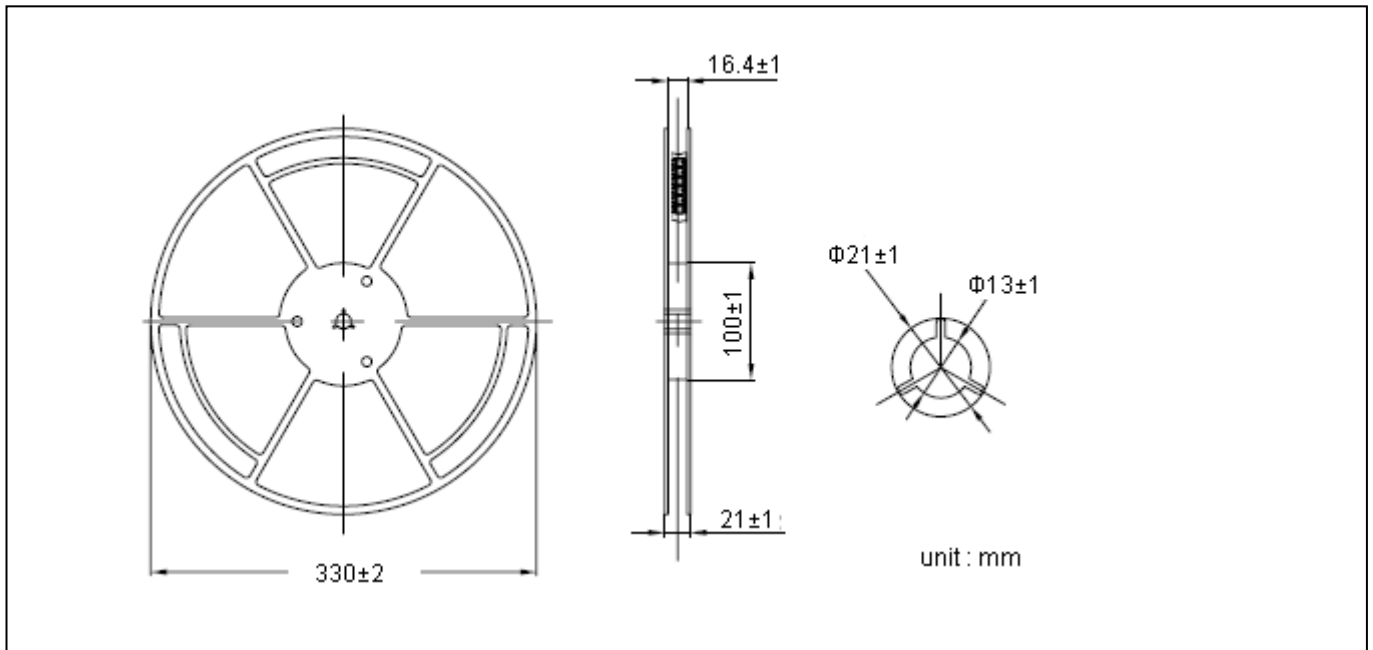
Single Pulse Power Rating, Junction to Case



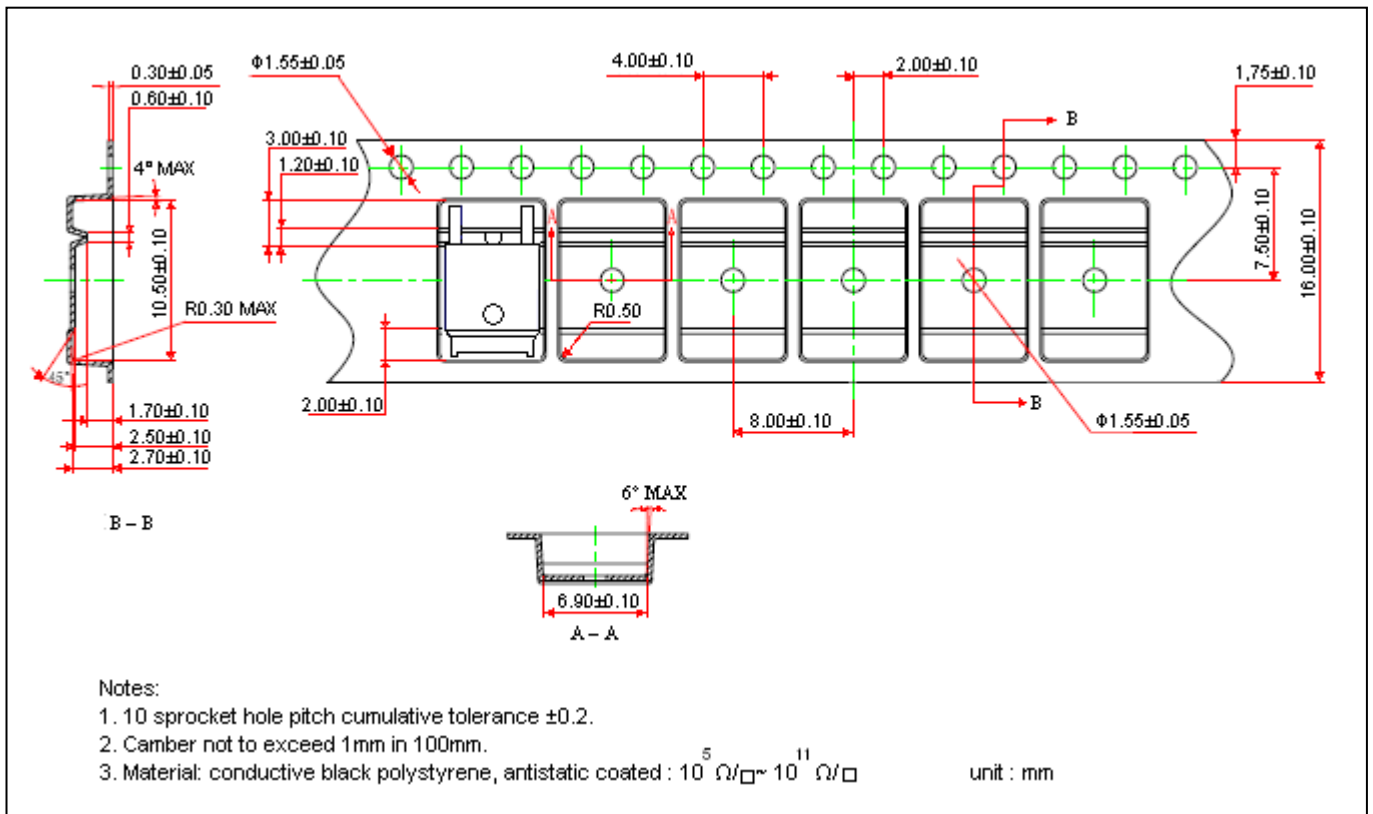
Transient Thermal Response Curves



Reel Dimension



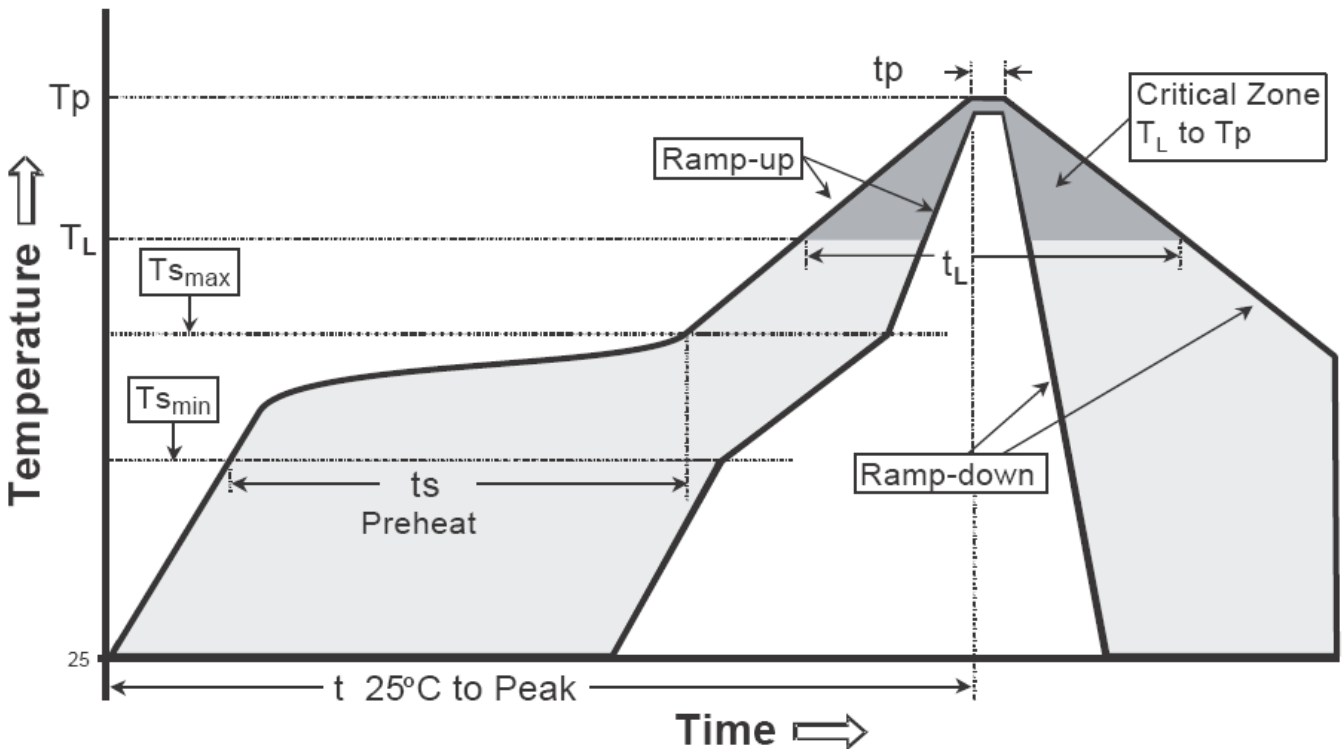
Carrier Tape Dimension



Recommended wave soldering condition

Product	Peak Temperature	Soldering Time
Pb-free devices	260 +0/-5 °C	5 +1/-1 seconds

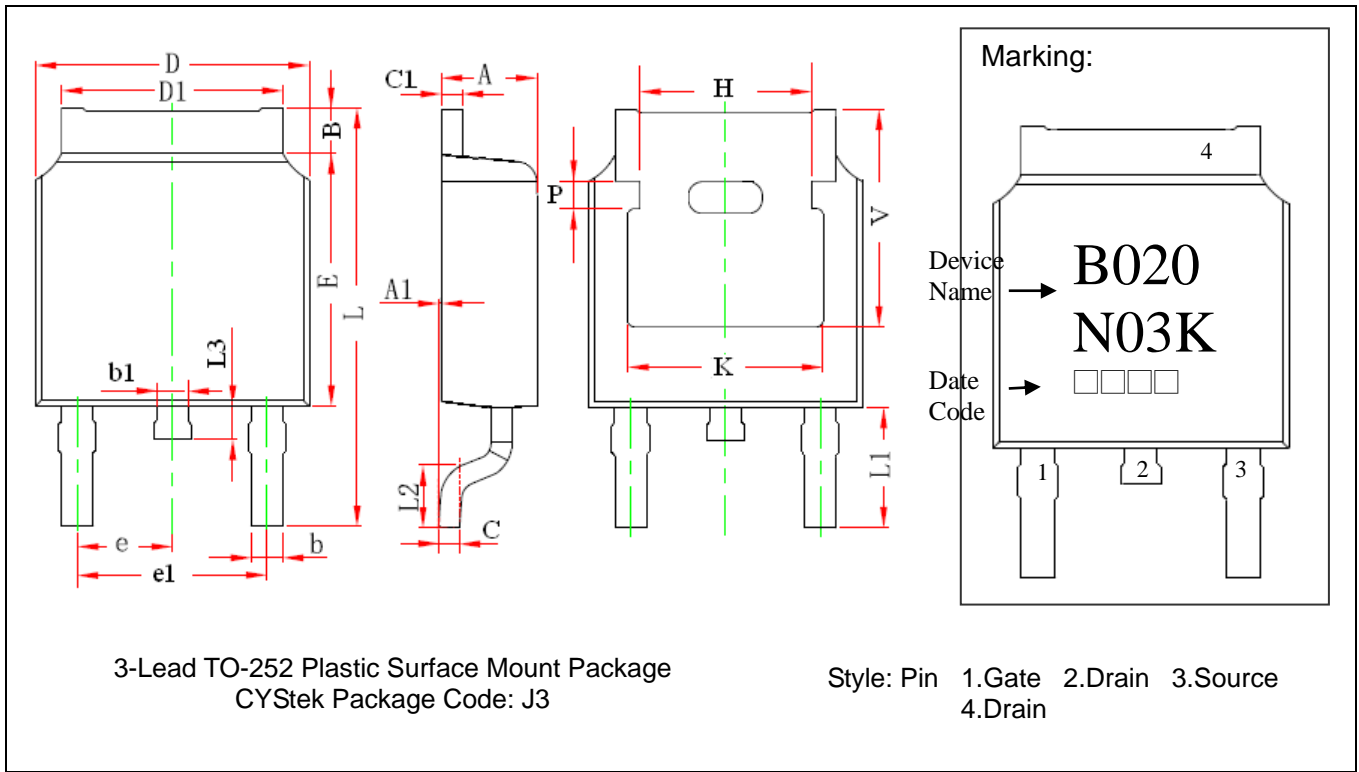
Recommended temperature profile for IR reflow



Profile feature	Sn-Pb eutectic Assembly	Pb-free Assembly
Average ramp-up rate (T _{smax} to T _p)	3°C/second max.	3°C/second max.
Preheat		
-Temperature Min(T _{s min})	100°C	150°C
-Temperature Max(T _{s max})	150°C	200°C
-Time(t _{s min} to t _{s max})	60-120 seconds	60-180 seconds
Time maintained above:		
-Temperature (T _L)	183°C	217°C
- Time (t _L)	60-150 seconds	60-150 seconds
Peak Temperature(T _P)	240 +0/-5 °C	260 +0/-5 °C
Time within 5°C of actual peak temperature(tp)	10-30 seconds	20-40 seconds
Ramp down rate	6°C/second max.	6°C/second max.
Time 25 °C to peak temperature	6 minutes max.	8 minutes max.

Note : All temperatures refer to topside of the package, measured on the package body surface.

TO-252 Dimension



DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.087	0.094	2.200	2.400	e	0.086	0.094	2.186	2.386
A1	0.000	0.005	0.000	0.127	e1	0.172	0.188	4.372	4.772
B	0.039	0.048	0.990	1.210	H	0.163	REF	4.140	REF
b	0.026	0.034	0.660	0.860	K	0.190	REF	4.830	REF
b1	0.026	0.034	0.660	0.860	L	0.386	0.409	9.800	10.400
C	0.018	0.023	0.460	0.580	L1	0.114	REF	2.900	REF
C1	0.018	0.023	0.460	0.580	L2	0.055	0.067	1.400	1.700
D	0.256	0.264	6.500	6.700	L3	0.024	0.039	0.600	1.000
D1	0.201	0.215	5.100	5.460	P	0.026	REF	0.650	REF
E	0.236	0.244	6.000	6.200	V	0.211	REF	5.350	REF

Notes: 1.Controlling dimension: millimeters.
 2.Maximum lead thickness includes lead finish thickness, and minimum lead thickness is the minimum thickness of base material.
 3.If there is any question with packing specification or packing method, please contact your local CYStek sales office.

Material:

- Lead : Pure tin plated.
- Mold Compound: Epoxy resin family, flammability solid burning class: UL94V-0.

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